

N-Channel Super Junction Power MOSFET

General Description

The series of devices use advanced super junction technology and design to provide excellent RDS(ON) with low gate charge. This super junction MOSFET fits the industry's AC-DC SMPS requirements for PFC, AC/DC power conversion, and industrial power applications.

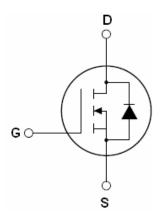
Features

- New technology for high voltage device
- Low on-resistance and low conduction losses
- Small package
- ●Ultra Low Gate Charge cause lower driving requirements
- ●100% Avalanche Tested
- ●ROHS compliant

Application

- Power factor correction (PFC)
- Switched mode power supplies(SMPS)
- Uninterruptible Power Supply (UPS)

V _{DS} @ <i>T</i> _{jmax}	560	V
R _{DS(ON)}	600	mΩ
I_D	7.8	A



Schematic diagram

Package Marking And Ordering Information

Device	Device Package	Marking
NCE08N50I	TO-251	NCE08N50I
NCE08N50K	TO-252	NCE08N50K





Table 1. Absolute Maximum Ratings (T_c=25℃)

TO-251 TO-252

Parameter	Symbol	Value	Unit
Drain-Source Voltage (V _{GS} =0V)	V _{DS}	500	V
Gate-Source Voltage (VDS=0V)	Vgs	±30	V
Continuous Drain Current at Tc=25°C	I _{D (DC)}	7.8	Α
Continuous Drain Current at Tc=100°C	I _{D (DC)}	5	Α
Pulsed drain current (Note 1)	I _{DM (pluse)}	23.4	А
Drain Source voltage slope, VDS = 400 V, ID = 7.8 A, Tj = 125 °C	dv/dt	50	V/ns
Maximum Power Dissipation(Tc=25℃)	P _D	83	W
Derate above 25°C		0.67	W/°C
Single pulse avalanche energy (Note 2)	Eas	230	mJ
Avalanche current ^(Note 1)	I _{AR}	7.8	А



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Parameter	Symbol	Value	Unit
Repetitive Avalanche energy , t_{AR} limited by T_{jmax} (Note 1)	E _{AR}	0.5	mJ
Operating Junction and Storage Temperature Range	T_{J}, T_{STG}	-55+150	°C

^{*} limited by maximum junction temperature

Table 2. Thermal Characteristic

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case (Maximum)	R _{thJC}	1.5	°C /W
Thermal Resistance, Junction-to-Ambient (Maximum)	R _{thJA}	75	°C /W

Electrical Characteristics (TA=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
On/off states						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250μA	500			V
Zero Gate Voltage Drain Current(Tc=25℃)	I _{DSS}	V _{DS} =500V,V _{GS} =0V			1	μΑ
Zero Gate Voltage Drain Current(Tc=125℃)	I _{DSS}	V _{DS} =500V,V _{GS} =0V			100	μΑ
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±30V,V _{DS} =0V			±100	nA
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} ,I _D =250μA	2.5	3	3.5	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =4.5A		540	600	mΩ
Dynamic Characteristics						
Forward Transconductance	g FS	V _{DS} = 20V, I _D =4.5A		6		S
Input Capacitance	C _{lss}	\/ -50\/\/ -0\/		860		pF
Output Capacitance	Coss	V_{DS} =50V, V_{GS} =0V, F=1.0MHz		68		pF
Reverse Transfer Capacitance	C _{rss}	F=1.UIVID2		5		pF
Total Gate Charge	Qg	\/ 400\/ 1 7.04		19.5	27	nC
Gate-Source Charge	Q_{gs}	V _{DS} =400V,I _D =7.8A,		3		nC
Gate-Drain Charge	Q_{gd}	V _{GS} =10V		7		nC
Intrinsic gate resistance	R _G	f = 1 MHz open drain		1.6		Ω
Switching times						
Turn-on Delay Time	t _{d(on)}			6		nS
Turn-on Rise Time	t _r	V _{DD} =380V,I _D =7.8A,		3.5		nS
Turn-Off Delay Time	$t_{d(off)}$	$R_G=12\Omega, V_{GS}=10V$		60	100	nS
Turn-Off Fall Time	t _f			7	15	nS
Source- Drain Diode Characteristics	•		•	•		
Source-drain current(Body Diode)	I _{SD}	T -25°C			7.8	Α
Pulsed Source-drain current(Body Diode)	I _{SDM}	- T _C =25°C			23.4	Α
Forward on voltage	V _{SD}	Tj=25°C,I _{SD} =7.8A,V _{GS} =0V		0.9	1.3	V
Reverse Recovery Time	t _{rr}	Tj=25°C,I _F =7.8A,di/dt=100A/μs		250		nS
Reverse Recovery Charge	Q _{rr}			2.6		uC
Peak reverse recovery current	I _{rrm}			21		Α

 $Notes\ 1. \\ \textit{Repetitive Rating: Pulse width limited by maximum junction temperature}$

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^{2.} Tj=25°C,VDD=50V,VG=10V, R_G=25 Ω



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS (curves)

Figure 1. Safe operating area

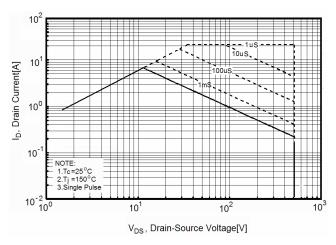


Figure 3. Output characteristics

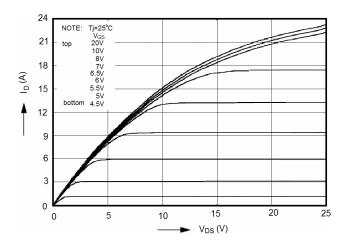


Figure 5. Static drain-source on resistance

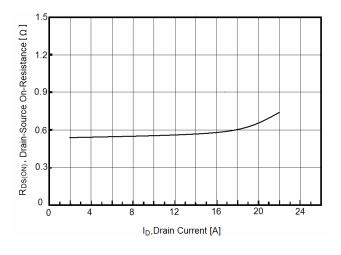


Figure 2. Source-Drain Diode Forward Voltage

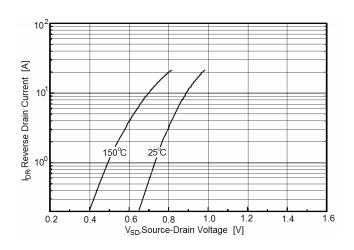


Figure 4. Transfer characteristics

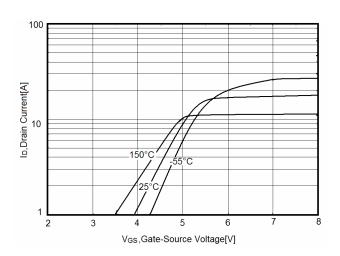


Figure 6. R_{DS(ON)} vs Junction Temperature

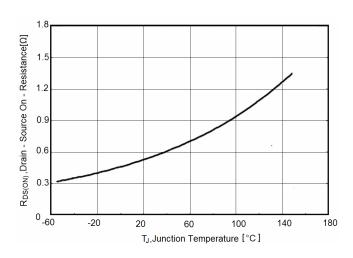






Figure 7. BV_{DSS} vs Junction Temperature

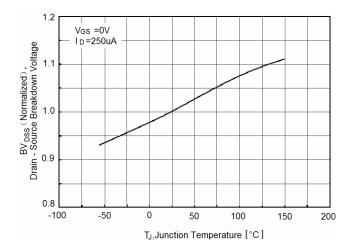


Figure9. Gate charge waveforms

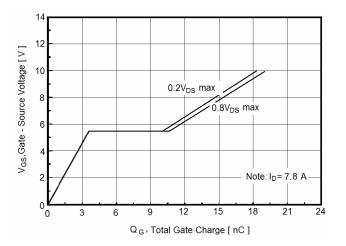


Figure 11. Transient Thermal Impedance

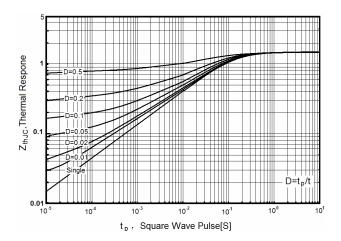


Figure 8. Maximum I_D vs Junction Temperature

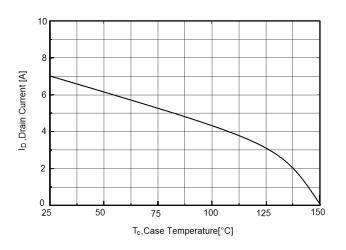
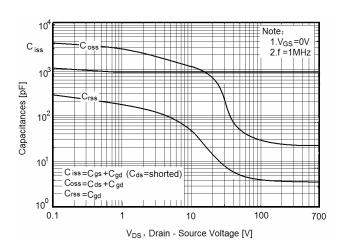


Figure 10. Capacitance



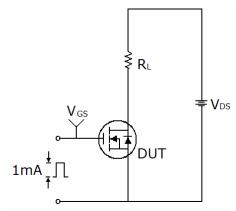


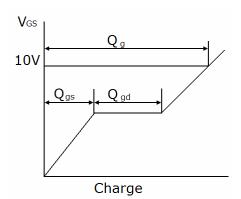




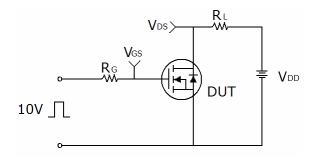
Test circuit

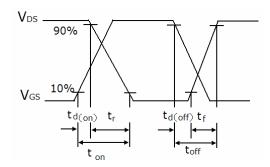
1) Gate charge test circuit & Waveform



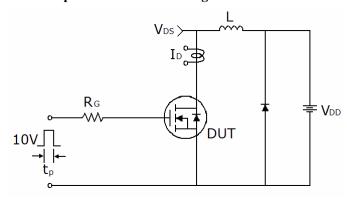


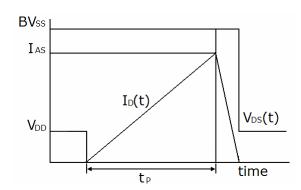
2) Switch Time Test Circuit:





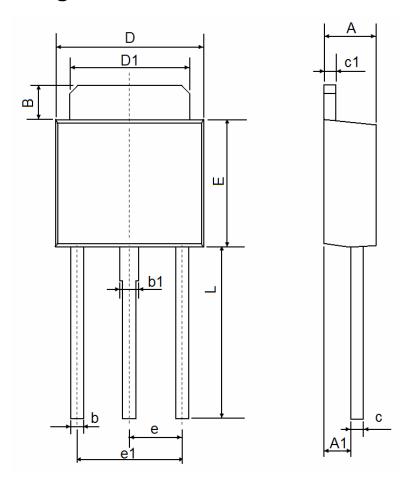
3) Unclamped Inductive Switching Test Circuit & Waveforms







TO-251 Package Information

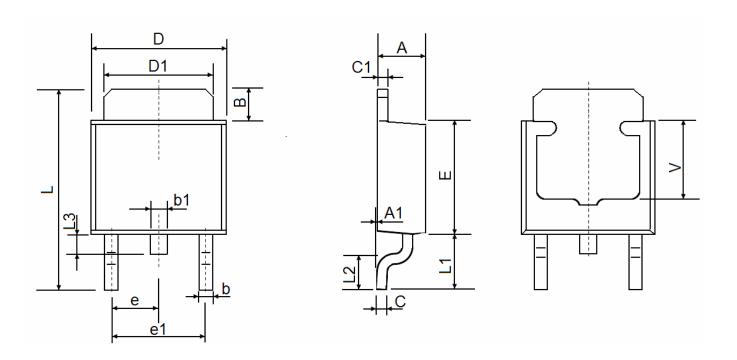


Symbol	Dimensions	In Millimeters	Dimensions In Inches		
	Min.	Max.	Min.	Max.	
А	2.200	2.400	0.087	0.094	
A1	1.050	1.350	0.042	0.054	
В	1.350	1.650	0.053	0.065	
b	0.500	0.700	0.020	0.028	
b1	0.700	0.900	0.028	0.035	
С	0.430	0.580	0.017	0.023	
c1	0.430	0.580	0.017	0.023	
D	6.350	6.650	0.250	0.262	
D1	5.200	5.400	0.205	0.213	
E	5.400	5.700	0.213	0.224	
е	2.300 TYP		0.091 TYP		
e1	4.500	4.700	0.177	0.185	
L	7.500	7.900	0.295	0.311	

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Symbol	Dimensions I	In Millimeters	Dimensions In Inches		
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A1	0.000	0.127	0.000	0.005	
В	1.350	1.650	0.053	0.065	
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b1	0.700	0.900	0.028	0.035	
С	0.430	0.580	0.017	0.023	
C1	0.430	0.580	0.017	0.023	
D	6.350	6.650	0.250	0.262	
D1	5.200	5.400	0.205	0.213	
Е	5.400	5.700	0.213	0.224	
е	2.300) TYP	0.091 TYP		
e1	4.500	4.700	0.177	0.185	
L	9.500	9.900	0.374	0.390	
L1	2.550	2.900	0.100	0.114	
L2	1.400	1.780	0.055	0.070	
L3	0.600	0.900	0.024	0.035	
V	3.800 REF		0.150	REF	

NCE08N50I,NCE08N50K



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